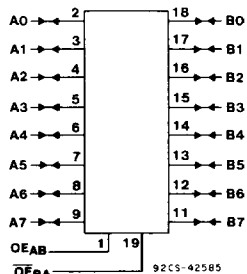


# CD54/74AC623 CD54/74ACT623



**FUNCTIONAL DIAGRAM**

## Octal-Bus Transceiver, 3-State, Non-Inverting

**Type Features:**

- Buffered inputs
- Typical propagation delay: 4.5 ns @  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$ ,  $C_L = 50\text{ pF}$

**Family Features:**

- Exceeds 2-kV ESD Protection - MIL-STD-883, Method 3015
- SCR-Latchup-resistant CMOS process and circuit design
- Speed of bipolar FAST\*/AS/S with significantly reduced power consumption
- Balanced propagation delays
- AC types feature 1.5-V to 5.5-V operation and balanced noise immunity at 30% of the supply
- $\pm 24\text{-mA}$  output drive current
  - Fanout to 15 FAST\* ICs
  - Drives 50-ohm transmission lines

\*FAST is a Registered Trademark of Fairchild Semiconductor Corp.

The RCA CD54/74AC623 and CD54/74ACT623 octal-bus transceivers use the RCA ADVANCED CMOS technology. They are non-inverting, 3-state, bidirectional transceiver-buffers that allow for two-way transmission from "A" bus to "B" bus or "B" bus to "A" bus, depending on the logic levels of the Output Enable ( $OE_{AB}$ ,  $\overline{OE}_{BA}$ ) inputs.

The dual Output Enable provision gives these devices the capability to store data by simultaneously enabling  $OE_{AB}$  and  $\overline{OE}_{BA}$ . Each output reinforces its input under these conditions, and when all other data sources to the bus lines are at high-impedance, both sets of bus lines will remain in their last states.

The CD74AC623 and CD74ACT623 are supplied in 20-lead dual-in-line plastic packages (E suffix) and in 20-lead dual-in-line small-outline plastic packages (M suffix). Both package types are operable over the following temperature ranges: Commercial (0 to 70°C); Industrial (-40 to +85°C); and Extended Industrial/Military (-55 to +125°C).

The CD54AC623 and CD54ACT623, available in chip form (H suffix), are operable over the -55 to +125°C temperature range.

**TRUTH TABLE**

OUTPUT ENABLE INPUTS		OPERATION
$\overline{OE}_{BA}$	$OE_{AB}$	
L	L	B DATA TO A BUS
H	H	A DATA TO B BUS
H	L	ISOLATION
L	H	B DATA TO A BUS, A DATA TO B BUS

H = High level, L = Low level

Note: To prevent excess currents in the High-Z (isolation) modes, all I/O terminals should be terminated with 10 kΩ to 1 MΩ resistors.

# Technical Data

## CD54/74AC623

## CD54/74ACT623

### MAXIMUM RATINGS, Absolute-Maximum Values:

DC SUPPLY-VOLTAGE ( $V_{CC}$ )	.....	-0.5 to 6 V
DC INPUT DIODE CURRENT, $I_{IK}$ (for $V_I < -0.5$ V or $V_I > V_{CC} + 0.5$ V)	.....	$\pm 20$ mA
DC OUTPUT DIODE CURRENT, $I_{OK}$ (for $V_O < -0.5$ V or $V_O > V_{CC} + 0.5$ V)	.....	$\pm 50$ mA
DC OUTPUT SOURCE OR SINK CURRENT per Output Pin, $I_O$ (for $V_O > -0.5$ V or $V_O < V_{CC} + 0.5$ V)	.....	$\pm 50$ mA
DC $V_{CC}$ or GROUND CURRENT ( $I_{CC}$ or $I_{GND}$ )	.....	$\pm 100$ mA*
POWER DISSIPATION PER PACKAGE ( $P_D$ ):		
For $T_A = -55$ to $+100^\circ\text{C}$ (PACKAGE TYPE E)	.....	500 mW
For $T_A = +100$ to $+125^\circ\text{C}$ (PACKAGE TYPE E)	.....	Derate Linearly at $8\text{ mW}/^\circ\text{C}$ to 300 mW
For $T_A = -55$ to $+70^\circ\text{C}$ (PACKAGE TYPE M)	.....	400 mW
For $T_A = +70$ to $+125^\circ\text{C}$ (PACKAGE TYPE M)	.....	Derate Linearly at $6\text{ mW}/^\circ\text{C}$ to 70 mW
OPERATING-TEMPERATURE RANGE ( $T_A$ )	.....	$-55$ to $+125^\circ\text{C}$
STORAGE TEMPERATURE ( $T_{stg}$ )	.....	$-65$ to $+150^\circ\text{C}$
LEAD TEMPERATURE (DURING SOLDERING):		
At distance $1/16 \pm 1/32$ in. ( $1.59 \pm 0.79$ mm) from case for 10 s maximum	.....	$+265^\circ\text{C}$
Unit inserted into PC board min. thickness $1/16$ in. ( $1.59$ mm) with solder contacting lead tips only	.....	$+300^\circ\text{C}$

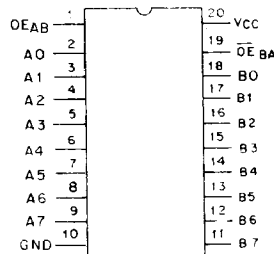
\*For up to 4 outputs per device; add  $\pm 25$  mA for each additional output.

### RECOMMENDED OPERATING CONDITIONS:

For maximum reliability, normal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	LIMITS		UNITS
	MIN.	MAX.	
Supply-Voltage Range, $V_{CC}$ *: (For $T_A =$ Full Package-Temperature Range) AC Types ACT Types	1.5	5.5	V
	4.5	5.5	V
DC Input or Output Voltage, $V_I, V_O$	0	$V_{CC}$	V
Operating Temperature, $T_A$	$-55$	$+125$	$^\circ\text{C}$
Input Rise and Fall Slew Rate, $dt/dv$ at 1.5 V to 3 V (AC Types) at 3.6 V to 5.5 V (AC Types) at 4.5 V to 5.5 V (ACT Types)	0	50	ns/V
	0	20	ns/V
	0	10	ns/V

\*Unless otherwise specified, all voltages are referenced to ground.



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### TERMINAL ASSIGNMENT

# CD54/74AC623 CD54/74ACT623

STATIC ELECTRICAL CHARACTERISTICS: AC Series

CHARACTERISTICS	TEST CONDITIONS		V <sub>CC</sub> (V)	AMBIENT TEMPERATURE (T <sub>a</sub> ) - °C						UNITS
				+25		-40 to +85		-55 to +125		
	V <sub>I</sub> (V)	I <sub>O</sub> (mA)		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
High-Level Input Voltage V <sub>IH</sub>			1.5	1.2	—	1.2	—	1.2	—	V
			3	2.1	—	2.1	—	2.1	—	
			5.5	3.85	—	3.85	—	3.85	—	
Low-Level Input Voltage V <sub>IL</sub>			1.5	—	0.3	—	0.3	—	0.3	V
			3	—	0.9	—	0.9	—	0.9	
			5.5	—	1.65	—	1.65	—	1.65	
High-Level Output Voltage V <sub>OH</sub>	V <sub>IH</sub> or V <sub>IL</sub> #,* {	-0.05	1.5	1.4	—	1.4	—	1.4	—	V
		-0.05	3	2.9	—	2.9	—	2.9	—	
		-0.05	4.5	4.4	—	4.4	—	4.4	—	
		-4	3	2.58	—	2.48	—	2.4	—	
		-24	4.5	3.94	—	3.8	—	3.7	—	
		-75	5.5	—	—	3.85	—	—	—	
Low-Level Output Voltage V <sub>OL</sub>	V <sub>IH</sub> or V <sub>IL</sub> #,* {	0.05	1.5	—	0.1	—	0.1	—	0.1	V
		0.05	3	—	0.1	—	0.1	—	0.1	
		0.05	4.5	—	0.1	—	0.1	—	0.1	
		12	3	—	0.36	—	0.44	—	0.5	
		24	4.5	—	0.36	—	0.44	—	0.5	
		75	5.5	—	—	—	1.65	—	—	
Input Leakage Current I <sub>I</sub>	V <sub>CC</sub> or GND		5.5	—	±0.1	—	±1	—	±1	μA
3-State Leakage Current I <sub>OZ</sub>	V <sub>IH</sub> or V <sub>IL</sub> V <sub>O</sub> = V <sub>CC</sub> or GND		5.5	—	±0.5	—	±5	—	±10	μA
Quiescent Supply Current, MSI I <sub>CC</sub>	V <sub>CC</sub> or GND	0	5.5	—	8	—	80	—	160	μA

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation.

\*Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

Technical Data  
**CD54/74AC623**  
**CD54/74ACT623**

STATIC ELECTRICAL CHARACTERISTICS: ACT Series

CHARACTERISTICS	TEST CONDITIONS	$V_{CC}$ (V)	AMBIENT TEMPERATURE ( $T_A$ ) - °C						UNITS	
			+25		-40 to +85		-55 to +125			
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
High-Level Input Voltage $V_{IH}$			4.5 to 5.5	2	—	2	—	2	—	V
Low-Level Input Voltage $V_{IL}$			4.5 to 5.5	—	0.8	—	0.8	—	0.8	V
High-Level Output Voltage $V_{OH}$	$V_{IH}$ or $V_{IL}$ #, *	-0.05	4.5	4.4	—	4.4	—	4.4	—	V
		-24	4.5	3.94	—	3.8	—	3.7	—	
		-75	5.5	—	—	3.85	—	—	—	
		-50	5.5	—	—	—	—	3.85	—	
Low-Level Output Voltage $V_{OL}$	$V_{IH}$ or $V_{IL}$ #, *	0.05	4.5	—	0.1	—	0.1	—	0.1	V
		24	4.5	—	0.36	—	0.44	—	0.5	
		75	5.5	—	—	—	1.65	—	—	
		50	5.5	—	—	—	—	—	1.65	
Input Leakage Current $I_I$	$V_{CC}$ or GND		5.5	—	±0.1	—	±1	—	±1	μA
3-State Leakage Current $I_{OZ}$	$V_{IH}$ or $V_{IL}$ $V_O = V_{CC}$ or GND		5.5	—	±0.5	—	±5	—	±10	μA
Quiescent Supply Current, MSI $I_{CC}$	$V_{CC}$ or GND	0	5.5	—	8	—	80	—	160	μA
Additional Quiescent Supply Current per Input Pin TTL Inputs High 1 Unit Load $\Delta I_{CC}$	$V_{CC}-2.1$		4.5 to 5.5	—	2.4	—	2.8	—	3	mA

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation.

\*Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

**ACT INPUT LOADING TABLE**

INPUT	UNIT LOAD*
$A_n, B_n$	0.83
$\overline{OE}_{BA}$	0.64
$OE_{AB}$	0.15

\*Unit load is  $\Delta I_{CC}$  limit specified in Static Characteristics Chart, e.g., 2.4 mA max. @ 25°C.

# CD54/74AC623

# CD54/74ACT623

SWITCHING CHARACTERISTICS: AC Series;  $t_r, t_f = 3 \text{ ns}$ ,  $C_L = 50 \text{ pF}$

CHARACTERISTICS	SYMBOL	$V_{CC}$ (V)	AMBIENT TEMPERATURE ( $T_A$ ) - °C				UNITS
			-40 to +85		-55 to +125		
			MIN.	MAX.	MIN.	MAX.	
Propagation Delays: Data to Output	$t_{PLH}$	1.5	—	108	—	120	ns
	$t_{PHL}$	3.3* 5†	3.5 2.5	12.2 8.7	3.4 2.4	13.4 9.6	
Output Disable to Output	$t_{PLZ}$	1.5	—	153	—	168	ns
	$t_{PHZ}$	3.3 5	4.8 3.5	17.1 12.2	4.7 3.4	18.8 13.4	
Output Enable to Output	$t_{PZL}$	1.5	—	153	—	168	ns
	$t_{PZH}$	3.3 5	4.8 3.5	17.1 12.2	4.7 3.4	18.8 13.4	
Power Dissipation Capacitance	$C_{PD}\S$	—	66 Typ.		66 Typ.		pF
Min. (Valley) $V_{OH}$ During Switching of Other Outputs (Output Under Test Not Switching)	$V_{OHV}$ See Fig. 1	5	4 Typ. @ 25°C				V
Max. (Peak) $V_{OL}$ During Switching of Other Outputs (Output Under Test Not Switching)	$V_{OLP}$ See Fig. 1	5	1 Typ. @ 25°C				V
Input Capacitance	$C_I$	—	—	10	—	10	pF
3-State Output Capacitance	$C_O$	—	—	15	—	15	pF

SWITCHING CHARACTERISTICS: ACT Series;  $t_r, t_f = 3 \text{ ns}$ ,  $C_L = 50 \text{ pF}$

CHARACTERISTICS	SYMBOL	$V_{CC}$ (V)	AMBIENT TEMPERATURE ( $T_A$ ) - °C				UNITS
			-40 to +85		-55 to +125		
			MIN.	MAX.	MIN.	MAX.	
Propagation Delays: Data to Output	$t_{PLH}$ $t_{PHL}$	5†	2.7	9.6	2.7	10.6	ns
	Output Disable to Output	$t_{PLZ}$ $t_{PHZ}$	5	3.7	13.1	3.6	
Output Enable to Output		$t_{PZH}$ $t_{PZL}$	5	3.7	13.1	3.6	14.4
	Power Dissipation Capacitance	$C_{PD}\S$	—	66 Typ.		66 Typ.	
Min. (Valley) $V_{OH}$ During Switching of Other Outputs (Output Under Test Not Switching)	$V_{OHV}$ See Fig. 1	5	4 Typ. @ 25°C				V
Max. (Peak) $V_{OL}$ During Switching of Other Outputs (Output Under Test Not Switching)	$V_{OLP}$ See Fig. 1	5	1 Typ. @ 25°C				V
Input Capacitance	$C_I$	—	—	10	—	10	pF
3-State Output Capacitance	$C_O$	—	—	15	—	15	pF

\*3.3 V: min. is @ 3.6 V  
max. is @ 3 V

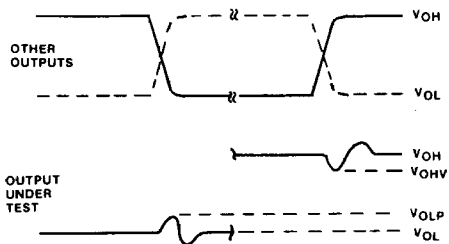
†5 V: min. is @ 5.5 V  
max. is @ 4.5 V

§ $C_{PD}$  is used to determine the dynamic power consumption, per channel.

For AC series:  $P_D = V_{CC}^2 f_i (C_{PD} + C_L)$

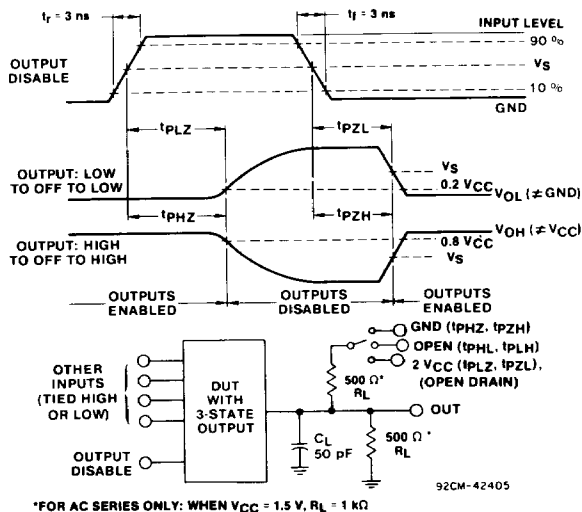
For ACT series:  $P_D = V_{CC}^2 f_i (C_{PD} + C_L) + V_{CC} \Delta I_{CC}$  where  $f_i$  = input frequency  
 $C_L$  = output load capacitance  
 $V_{CC}$  = supply voltage.

**PARAMETER MEASUREMENT INFORMATION**



- NOTES:**
1.  $V_{OHV}$  AND  $V_{OLP}$  ARE MEASURED WITH RESPECT TO A GROUND REFERENCE NEAR THE OUTPUT UNDER TEST.
  2. INPUT PULSES HAVE THE FOLLOWING CHARACTERISTICS:  $PRR \leq 1$  MHz,  $t_r = 3$  ns,  $t_f = 3$  ns, SKEW 1 ns.
  3. R.F. FIXTURE WITH 700-MHz DESIGN RULES REQUIRED. IC SHOULD BE SOLDERED INTO TEST BOARD AND BYPASSED WITH  $0.1 \mu F$  CAPACITOR. SCOPE AND PROBES REQUIRE 700-MHz BANDWIDTH.

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\*FOR AC SERIES ONLY: WHEN  $V_{CC} = 1.5$  V,  $R_L = 1$  k $\Omega$

Fig. 1 - Simultaneous switching transient waveforms.

Fig. 2 - Three-state propagation delay times and test circuit.

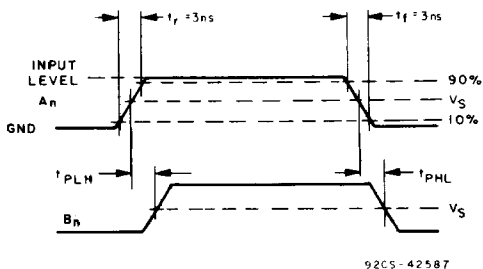
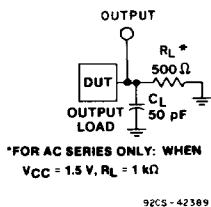


Fig. 3 - Propagation delay times and test circuit.

	CD54/74AC	CD54/74ACT
Input Level	$V_{CC}$	3 V
Input Switching Voltage, $V_S$	$0.5 V_{CC}$	1.5 V
Output Switching Voltage, $V_S$	$0.5 V_{CC}$	$0.5 V_{CC}$